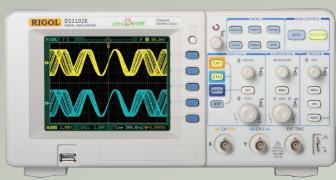
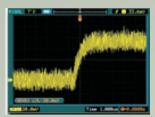
scientific

Digital Oscilloscopes



DS1052D: 50 MHz DS1102D: 100 MHz DS1052E: 50 MHz DS1102E: 100 MHz





Adjustable Trigger Sensitivity



Rising & Falling Edge Trigger



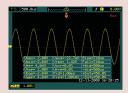
Slope Trigger



Alternate Trigger

- Sampling Rate , Real Time : 1GSa/s
- Equivalent Sampling up to 10 GSa/s / 25 GSa/s
- Dual Analog Channel 50 MHz & 100 MHz
- Unique Waveform Record & Replay
- 16 channel logic analyzer in DS1000D Series
- Automatically measures 20 types of wave parameters
- 64 k color TFT LCD
- Built-in FFT
- Wide selection of trigger types : Edge, Pulse Width, Slope, Video, Alternate, Pattern & Duration
- Fine delayed scan function
- Unique adjustable trigger sensitivity
- Exclusive digital filters to capture noisy signals
- Standard USB device, USB Host, Rs232 interface
- Support USB flash memory for mass storage
- Powerful PC application software Ultra Scope
- Direct printing to PictBridge print standards

Automatically Measure 20 Wave Parameters



Automatic measure



DS1000E, DS1000D series oscilloscope provide 20 types of wave parameters for automatically measuring which contains 10 Voltage & 10 Time parameters.

In cursor mode, users can easily measure by moving cursor. Besides, 3 types of cursor measurement are Optional: Manual, Track & Auto

Cursor Measure



FFT cursor measure

Multiple Trigger





Both DS1000E and DS1000D series contain abundant triggers:

- Edge trigger, Pulse Width trigger, Video trigger, Slope trigger
- Alternate trigger, Pattern trigger (DS1000D), Duration trigger (DS1000D)

Especially the duration trigger is a new type from perfect combination of patten and pulse width trigger . Unique function of adjustable trigger sensitivity is good for filtering possible noise from signal in order to avoid false triggers.

Pattern trigger

16 Channels Logic Analyzer

Being equipped with 16 channels logic analyzer, DS1000D series mixed signal oscilloscope achieve mixed signal measure co-ordinating with 2 analog channels.





Each channel can be turned on or off independently, or in group of 8(D7-D0 & D15-D8); also you can set waveform size and threshold types or change the display position on screen for digital channel.

Digital Channels Setup

Waveform Recording

In Virtue of waveforms recording function from DS1000E & DS1000D series, not only the outputs from two channels could be recorded, but also the waves outputted by Pass/Fail test could be easily recorded. Totally, upto 1000 frames of waves are available to record. Besides, users can analyze waves according to recall or save transient waves so as to get more exact datum.





Waveform recording

Pass/Fail Testing

The Pass/Fail function monitors changes of signals by comparing whether the input signal is within the pe-defined mask. The testing results not only can be displayed on screen or output by isolated pass/fail port, but also can be alarmed according to relevant system sound settings.



Pass/Fail testing

UltraScope Software

Powerful PC application software: UltraScope, which enables to: Capture & measure wave, Perform local or remote operation; Save waves as ".bmp" format; Save files as ".txt" or ".xls" format, Print Waveforms.

Measurement window



KeyLock Function

Key Lock



This function is idely used in most productions. All keys are locked except F1 to F5 and MENU ON/OFF in this mode.

To lock the keyboard, use menu; to unlock, correct code has to be input. Also, you can reset a new code if necessary.

Technical Specifications

	10 GSa/s 16 channel logic + Dual cha <7.0 ns When vertical displacement When vertical displacement Under same setting & condition	8 bits 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	ent Sample, Average, Roll a/s 10 GSa/s Dual channels + s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	25 GSa/s External Trigger <3.5 ns • 0.1 div+1 mV)				
Memory Depth Sample Modes Real Time Sample Rate Equivalent Sample Rate Number of Channels Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	10 GSa/s 16 channel logic + Dual cha <7.0 ns When vertical displacement When vertical displacement Under same setting & condition	k / 1 M points (Single channel) Real-Time Sample & Equivale 1 GSa 25 GSa/s annels + External Trigger 8 bit: 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 3	; 8k / 512 k points (Dual channels ent Sample, Average, Roll a/s 10 GSa/s Dual channels + s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	25 GSa/s External Trigger <3.5 ns • 0.1 div+1 mV)				
Sample Modes Real Time Sample Rate Equivalent Sample Rate Number of Channels Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	10 GSa/s 16 channel logic + Dual cha <7.0 ns When vertical displacement When vertical displacement Under same setting & condition	Real-Time Sample & Equivale 1 GSa 25 GSa/s 25 GSa/s 2 mV/div to 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	ent Sample, Average, Roll a/s 10 GSa/s Dual channels + s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	25 GSa/s External Trigger <3.5 ns • 0.1 div+1 mV)				
Real Time Sample Rate Equivalent Sample Rate Number of Channels Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	16 channel logic + Dual cha	1 GSa 25 GSa/s annels + External Trigger 8 bit 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 3	a/s 10 GSa/s Dual channels + s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	External Trigger <3.5 ns · 0.1 div+1 mV)				
Equivalent Sample Rate Number of Channels Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	16 channel logic + Dual cha	25 GSa/s annels + External Trigger 8 bit: 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 3	10 GSa/s Dual channels + s 10 V/div 0 mV/div to 10 V/div : ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	External Trigger <3.5 ns · 0.1 div+1 mV)				
Number of Channels Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	16 channel logic + Dual cha	8 bits 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	Dual channels + s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	External Trigger <3.5 ns · 0.1 div+1 mV)				
Vertical Resolution Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	<7.0 ns When vertical displacement When vertical displacement Under same setting & condition	8 bits 2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	s 10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns c(DC Gain Accuracy x reading + Verticent) + 0.2 div] 2 mV/div to 245 mV/div	<3.5 ns				
Vertical Sensitivity DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	<7.0 ns When vertical displacement When vertical displacement Under same setting & condition	2 mV/div to 2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	10 V/div 0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Verticent) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
DC Gain Accuracy Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	<7.0 ns When vertical displacement When vertical displacement Under same setting & condition	2 mV/div - 5 mV/div : ±4%, 1 ± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	0 mV/div to 10 V/div: ± 3% ± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Verticent) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
Offset Range Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	<7.0 ns When vertical displacement When vertical displacement Under same setting & condition	± 40 V (500 mV/div ~ 10 V/div), ≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 2	± 2 V(2 mV/div ~ 100 mV/div) t input BNC) <7.0 ns (DC Gain Accuracy x reading + Vertical Accuracy x (reading + Vertical) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
Lower Freq. Response Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	<7.0 ns When vertical displacement When vertical displacement Under same setting & condition	≤ 5 Hz (at <3.5 ns clacement is zero, and N≥16:± ent is not at zero & N≥16:±[DC Vertical displacem Add 2 mV for setting from the	t input BNC) <7.0 ns (DC Gain Accuracy x reading + Gain Accuracy x(reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
Rise Time at BNC DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	When vertical displacements When vertical displacements When vertical displacements When vertical displacements	<3.5 ns placement is zero, and N≥16:± ent is not at zero & N≥16:±[DC Vertical displacem Add 2 mV for setting from the	<7.0 ns (DC Gain Accuracy x reading + verticent) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
DC Measurement Accuracy Average Acquisition Mode Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	When vertical displacements When vertical displacements When vertical displacements When vertical displacements	olacement is zero, and N≥16 : ± ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from 3	_(DC Gain Accuracy x reading + Gain Accuracy x(reading + vertinent) + 0.2 div] 2 mV/div to 245 mV/div	· 0.1 div+1 mV)				
Delta Volts Measurement Accuracy (Average Acquisition Mode) Input Impedance	When vertical displacement with the condition of the condition of the condition when the condition with the condition of the	ent is not at zero & N≥16 : ±[DC Vertical displacem Add 2 mV for setting from t	Gain Accuracy x(reading + veri nent) + 0.2 div] 2 mV/div to 245 mV/div					
Accuracy (Average Acquisition Mode) Input Impedance			When vertical displacement is zero, and N≥16 : ±(DC Gain Accuracy x reading + 0.1 div+1 mV) When vertical displacement is not at zero & N≥16 : ±[DC Gain Accuracy x(reading + vertical displacement)+(1% of Vertical displacement) + 0.2 div] Add 2 mV for setting from 2 mV/div to 245 mV/div Add 50 mV for setting > 250 mV/div to 10 V/div					
	Under same setting & condition, the voltage difference (ΔV) between any two points in the waves coming from the Average, of more than 16 waves than 16 waves have been acquired: \pm (DC Gain Accuracy x reading + 0.05 div)							
Probe Attenuation Factor	1 M Ω \pm 2%, in parallel with 18 pF \pm 3 pF							
1 1000 Attoridation 1 dotor	1X, 5X, 10X, 50X, 100X, 500X, 1000X							
Input Coupling	DC, AC, GND							
Max Input Voltage	400 V (DC+AC Peak, 1MΩ input impedance) 400 V (DC+AC Peak, 1MΩ input impedance) 400 V (DC+AC Peak, 1MΩ input impedance)							
Time Delay between Channel	500 ps							
Waveform Interpolation	sinx/x							
Time Base 5	5 ns to 50 s/div in 1-2-5 seq.	2 ns to 50 s/div in 1-2-5 seq.	5 ns to 50 s/div in 1-2-5 seq.	2 ns to 50 s/div in 1-2-5 seq.				
Roll Range	500 ms/div to 50 s/div							
Delay Time Accuracy	±50 ppm (any interval ≥1 ms)							
Delta Time Measurement Accuracy (Full Bandwidth)	Single-Shot : \pm (1 sample interval + 50 ppm x reading + 0.6 ns) >16 averages : \pm (1 sample interval + 50 ppm x reading + 0.4 ns)							
Trigger Modes E	Edge, Video, Pulse-width, AC	C-Line, Slope, Pattern, Duration	Edge, Video, Pulse-w	ridth, AC-Line, Slope				
Trigger Sources	CH 1, CH 2, EXT, Alternative							
Trigger Sensitivity	0.1 div – 1.0 div (adjustable)							
Trigger Level Range	Internal : ±6 V div from centre of screen; Ext : ±1.2 V							
Trigger Level Accuracy	Internal: \pm (0.3 div x V/div)(\pm 4 div from centre of screen), Ext: \pm (6% of setting + 200 mV)							
Trigger Offset	Normal Mode: Pre trigger(memory depth / 2 *sample Rate), Delayed Trigger: 1 s, Slow Scan Mode: Pre-trigger 6 div, delayed trigger 6 div							
Trigger Hold Off	500 ns - 1.5 s							
Edge Trigger	Edge trigger slope: Rising, Falling, Rising + Falling							
Pulse Width Trigger	Trigger condition (>, <, =) Positive Pulse, (>, <, =) negative pulse, Width Setting: 20n s - 10 s							
Video Trigger	Video Standard : NTSC, PAL, SECAM, Line Frequency : NTSC(1-525), PAL/SECAM(1 – 625)							
Alternate Trigger	Trigger on CH 1 & CH2 : Edge, Pulse Width, Video, Slope							
Slope Trigger	Trigger cond	lition (>, <, =) Positive Pulse, (>,	Trigger condition (>, <, =) Positive Pulse, (>, <, =) negative pulse, Time Setting : 20 ns -10 s					

Technical Specifications

Charifications	DS1052D	DS1102D	DS1052E	DS1102E		
Specifications			D31032E	DSTIUZE		
Logic Channel Sample Rate	200 N	MSa/s				
Pattern Trigger	Pattern type : D0 – D	015 select H, L, X, ₹, ₹	-			
Duration Trigger		ect H, L, X, Qualifier : >, <, =, : 20 ns - 10 s	-			
Auto Measure	Vpp, Vamp, Vmax, Vmin, Vtop, Vbase, Vavg, Vrms, Overshoot, Preshoot, Freq, Period, Rise Time, Fall Time + Width, -Width, +Duty, -Duty, Delay 1 →2 ₹.					
Cursor Measurements	Manual , Automatic & Track					
Math Functions	Add, Subtract, Multiply, FFT, Invert					
Storage	10 Setups and 10 Waveforms , USB : BMP, CSV, Waveforms and setups					
Average	selectable (2, 4, 8,16, 32, 64, 128 & 256)					
I/O	USB host, USB device, RS232 & P/F Out (Isolated)					
Display	5.7 inch TFT (64 k, Color LCD), 320 x 234 pixels					
Power	100V - 240 VACrms, 45 Hz to 440 Hz, 50 VA, CAT II					
Power Consumption	Less than 50 VA					
Operating Conditions	10° C to 40°C, RH 90%					
Dimension & Weight	W 30 D 133 H 154 mm, 2.3 kgs					
Standard Accessories	1:1 & 10:1 Passive Probe CD ROM, Positive Logic F	ual, Probe(1.5 m): 2 nos., is, USB Cable, Data Cable, Probe, 20 Logic Testing Nips, esting Cables	1:1 & 10:1 Passive Probe	ual, Probe(1.5 m) : 2 nos., s, USB Cable, Data Cable, ROM		
Optional Accessories	BNC cable, USB to GPIB adapter, 50 Ω termination (Subject to change)					







Power Cord

RS232 Cable

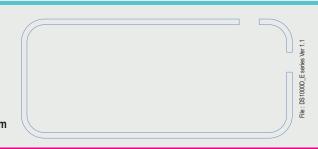
CD-ROM

scientific®

Scientific Mes-technik Pvt. Ltd.

B-14, Pologround, Industrial Estate, Indore 452 015, India

20731-2422330 /31 /32 /33 ■ 0731-2422334, 2561641 ☑ info@scientificindia.com



Allahabad (0532) 2260833 $\mbox{\promptile allahabad@scientificindia.com}$ Bengaluru (080) 23437635, 23331478 $\mbox{\promptile allahabad@scientificindia.com}$ Chennai (044) 24424598, 42054180 $\mbox{\promptile allahabad@scientificindia.com}$ Hyderabad (040) 27534995,27534996 $\mbox{\promptile allahabad@scientificindia.com}$

 Kolkata
 (033) 22282223-6

 □ kolkata@scientificindia.com

 Mumbai
 (022) 24333654, 24211171

 □ mumbai@scientificindia.com

 New Delhi
 (011) 65638100, 65638101

 □ ndelhi@scientificindia.com

 Pune
 (020) 26114688, 26132882

 □ pune@scientificindia.com